

**Notice of References Cited**

Application/Control No.

10/840,225

Applicant(s)/Patent Under  
Reexamination  
CHEN ET AL.

Examiner

Syed Y. Hasan

Art Unit

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Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2001/0043799	11-2001	Okada et al.	386/95
*	B	US-6,792,000	09-2004	Morinaga et al.	370/473
*	C	US-2001/0016432	08-2001	Yamauchi et al.	439/34
*	D	US-6,597,862	07-2003	Saeki et al.	386/125
*	E	US-6,150,925	11-2000	Casazza, Jeffrey P.	340/425.5
*	F	US-6,767,253	07-2004	Werner et al.	439/638
*	G	US-6,996,731	02-2006	Obitsu, Toshiro	713/324
*	H	US-6,618,832	09-2003	Schweidler et al.	714/776
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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